

N t i c o f R e f e r e n c e s C i t e d

Application/Control No.

09/333,049

Applicant(s)/Patent Under
Reexamination
HIRANO ET AL.

Examiner

Hoai V Pham

Art Unit

2814

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
	A	US-6174766B1	01-2001	Hayashi et al.	438	241
	B	US-				
	C	US-				
	D	US-				
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